infineon

MOSFET

Metall Oxide Semiconductor Field Effect Transistor

CoolMOS E6

650V CoolMOS^{TM} E6 Power Transistor
IPx65R600E6

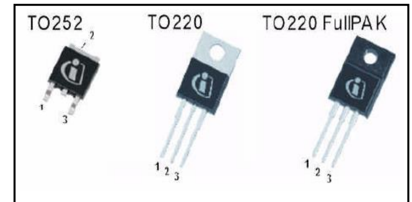
Data Sheet

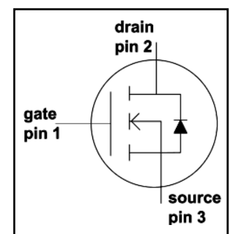
Rev. 2.2, 2016-08-04

Power Management & Multimarket

1 Description

CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ DE series combines the experience of the leading SJ MOSFET supplier with high class innovation. The resulting devices provide all benefits of a fast switching SJ MOSFET while not sacrificing ease of use. Extremely low switching and conduction losses make switching applications even more efficient, more compact, lighter, and cooler.





Features

- Extremely low losses due to very low F O M R dson*Qg and E oss
- Very high commutation ruggedness
- Easy to use/drive
- JEDEC[1] qualified, Pb-free plating, available in Halogen free mold compound [2]

Applications

PFC stages, hard switching PWM stages and resonant switching PWM stages e.g. PC Silverbox, Adapter, LCD & PDP TV, Lightning, Server, Telecom and UPS.

Please note: For MOSFET paralleling the use o fferrite beads on the gate or separate totem poles is generally recommended.

Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DS} @$T_{j\ max}$	700	V
$R_{DS(on),\ max}$	0.6	Ω
$Q_{G,\ typ}$	23	nC
$I_{D,\ pulse}$	18	A
E_{oss} @ 400V	2	µJ
Body diode di/dt	500	A/µs

Type / Ordering Code	Package	Marking	Related links
IPD65R600E6	PG-TO252	65E6600	IFX CoolMOS Webpage IFX Design tools
IPP65R600E6	PG-TO220		
IPA65R600E6	PG-TO220 FullPAK		

1) J-STD20 and JESD22
2) For PG-TO252: non-Halogen free (OPN: IPD65R600E6BT); Halogen free (OPN: IPD65R600E6AT)

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2 Maximum ratings

At T_j = 25 °C, unless otherwise specified.

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Continuous drain current [1]	I_D	–	–	7.3	A	$T_C = 25°C$
		–	–	4.6		$T_C = 100°C$
Pulsed drain current [2]	$I_{D, pulse}$	–	–	18		$T_C = 25°C$
Averlanche energy, single pulse	E_{AS}	–	–	142	mJ	$I_D = 1.3A$; $V_{DD} = 50V$; $T_C = 25°C$ (see Table 11)
Averlanche energy, repetitive	E_{AR}	–	–	0.21		I_D=1.3 A, V_{DD}=50V
Avalanche current, repetitive	I_{AR}	–	–	1.3	A	
MOSFET dv/dt ruggedness	dv/dt	–	–	50	V/ns	V_{DS}=0…480 V
Gate source voltage	V_{GS}	-20	–	20	V	static
		-30		30		AC (f >1 Hz)
Power dissipation for Non FullPAK	P_{tot}	–	–	63	W	$T_C = 25°C$
Power dissipation for FullPAK	P_{tot}	–	–	28	W	$T_C = 25°C$
Operating and storage temperature	T_j, T_{stg}	-55	–	150	°C	
Mounting torque TO-220		–	–	60	Ncm	M3 and M3.5 screws
Mounting torque TO-220 FullPAK		–	–	50		M2.5 Screws
Continous diode forward current	I_S	–	–	6.3	A	$T_C = 25°C$
Diode pulse current [2]	$I_{S, pulsed}$	–	–	18	A	$T_C = 25°C$
Reverse diode dv/dt [3]	dv/dt	–	–	15	V/ns	V_{DS}=0…480 V, $I_{SD} \leq I_D$, $T_C = 125°C$ (see table 22)
Maxumum diode commutation speed [3]	di_f/dt			500	A/µs	

1) Limited by $T_{j, max.}$ Maximum duty cycle D=0.75
2) Pulse width t_p limited by $T_{j, max}$
3) Identical low side and high side switch with identical R_G

3 Thermal characteristics

Table 3 Thermal characteristics TO-220 (IPP65R600E6)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	–	–	2.0	°C/W	
Thermal resistance, junction-ambient	R_{thJA}	–	–	62		leaded
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	–	–	260	°C	1.6mm (0.063 in.) from case for 10 s

Table 4 Thermal characteristics TO-220 FullPAK (IPA65R600E6)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	–	–	4.5	°C/W	
Thermal resistance, junction-ambient	R_{thJA}	–	–	80		leaded
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	–	–	260	°C	1.6mm (0.063 in.) from case for 10 s

Table 5 Thermal characteristics TO-252 (IPD65R600E6)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	–	–	2.0	°C/W	
Thermal resistance, junction-ambient	R_{thJA}	–	–	62		SMD version, device on PCB, minimal footprint
			35			SMD version, device on PCB, 6cm^2 cooling area[1)]
Soldering temperature, wave- &reflowsoldering only allowed	T_{sold}	–	–	260	°C	Reflow MSL1

1) Device on 40mm*40mm*1.5 epoxy PCB FR4 with 6cm^2 (one layer, 70µm thick) copper area for drain connection. PCB is vertical without air stream cooling.

4 Electrical characteristics

Electrical characteristics, at T_j=25°C, unless otherwise specified

Table 6 Static characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Drain-source Breakdown voltage	$V_{(BR)DSS}$	650	–	–	V	V_{GS}= 0V, I_D= 1.0mA
Gate threshold voltage	$V_{GS(th)}$	2.5	3	3.5		V_{DS}= V_{GS}, I_D= 0.21mA
Zero gate Voltage drain current	I_{DSS}	–	–	1	µA	V_{DS}=600 V, V_{GS}=0V, T_j=25°C
		–	10	–		V_{DS}=600 V, V_{GS}=0V, T_j=150°C
Gate- source leakage current	I_{GSS}	–	–	100	nA	V_{GS}= 20V, V_{DS}= 0V
Drain- source on- state resistance	$R_{DS(on)}$	–	0.54	0.6	Ω	V_{GS}= 10V, I_D=2.1A, T_j= 25°C
		–	1.40	–		V_{GS}= 10V, I_D=2.1A, T_j= 150°C
Gate resistance	R_G	–	10.5	–	Ω	f= 1MHz, open drain

Table7 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	–	440	–	pF	V_{GS}= 0V, V_{DS}= 100V, f= 1MHz
Output capacitance	C_{oss}	–	30	–		
Effective output capacitance, energy related[1)]	$C_{o(er)}$	–	21	–		V_{GS}= 0V, V_{DS}=0…480V
Effective output capacitance, time related[2)]	$C_{o(tr)}$	–	88	–		I_D= const V_{GS}= 0V, V_{DS}=0…480 V
Turn- on delay time	$t_{d(on)}$	–	10	–	ns	V_{DD}=400 V V_{GS}=13 V, I_D=3.2A, R_G= 6.8 Ω (see table 20)
Rise time	t_r	–	8	–		
Turn- off delay time	$t_{d(off)}$	–	64	–		
Fall time	t_f	–	11	–		

1) $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$

2) $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$

Table 8 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{GS}	–	2.75	–	nC	V_{DD}= 480V, I_D= 3.2A, V_{GS}=0 to 10 V
Gate to drain charge	Q_{GD}	–	12	–		
Gate charge, total	Q_G	–	23			
Gate plateau voltage	$V_{plateau}$	–	5.5	–	V	

Table 8 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}	–	0.9	–	V	V_{GS}=0V, I_F=3.2A, T_j=25°C
Reverse recovery time	t_{rr}	–	270	–	ns	V_R=400 V, I_F=3.2A, diF/d_t=100 A/µs (see table 22)
Reverse recovery charge	Q_{rr}	–	2.0	–	nC	
Peak reverse recovery current	I_{rrm}	–	13	–	A	

5 Electrical characteristics diagrams

Table 10

Power dissipation Non FullPAK	Power dissipation FULLPAK
$P_{tot} = f(T_C)$	$P_{tot} = f(T_C)$

Table 11

Max. transient thermal impedance Non FullPAK	Max. transient thermal impedance Non FullPAK
$Z_{(thJC)}$=f(tp); parameter: $D=t_p/T$	$Z_{(thJC)}$=f(tp); parameter: $D=t_p/T$

Table 12

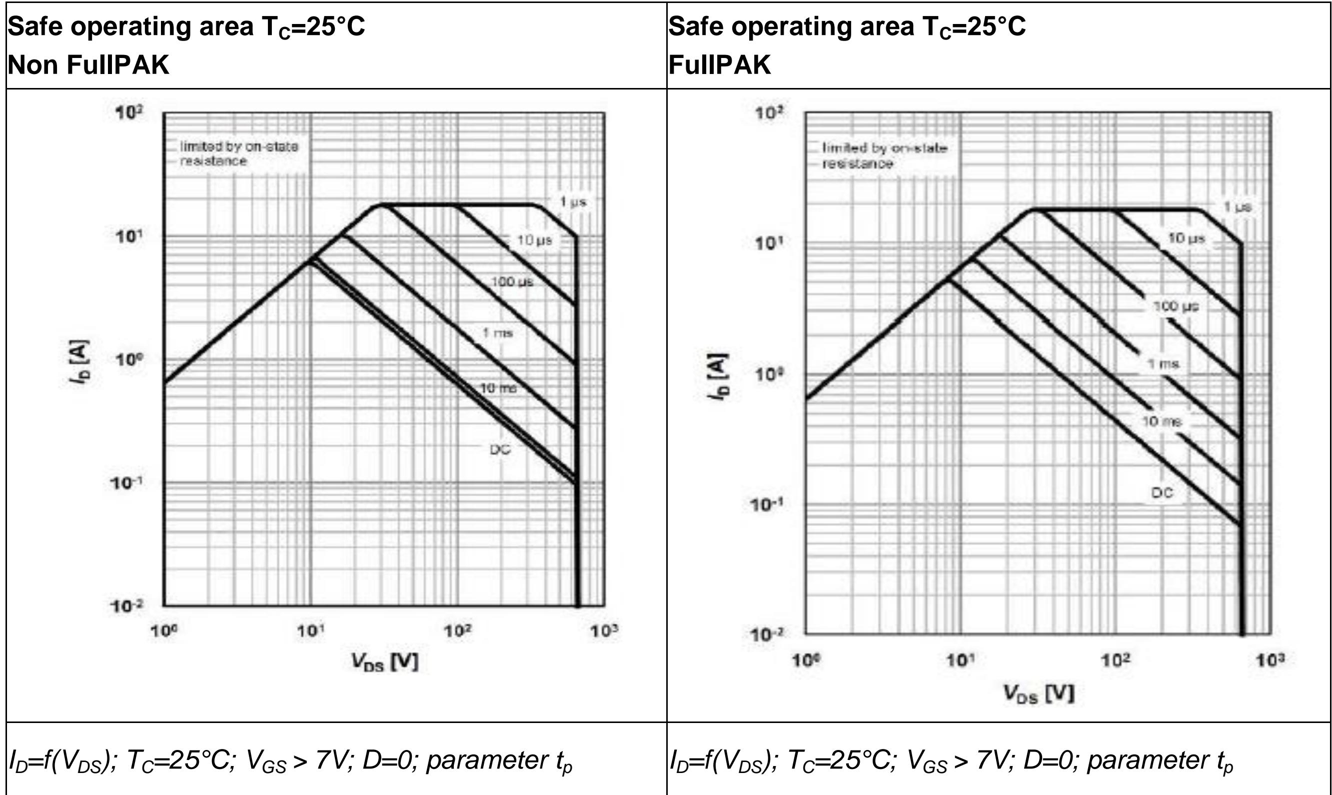
Safe operating area T_C=25°C Non FullPAK	Safe operating area T_C=25°C FullPAK
	
$I_D=f(V_{DS})$; T_C=25°C; V_{GS} > 7V; D=0; parameter t_p	$I_D=f(V_{DS})$; T_C=25°C; V_{GS} > 7V; D=0; parameter t_p

Table 13

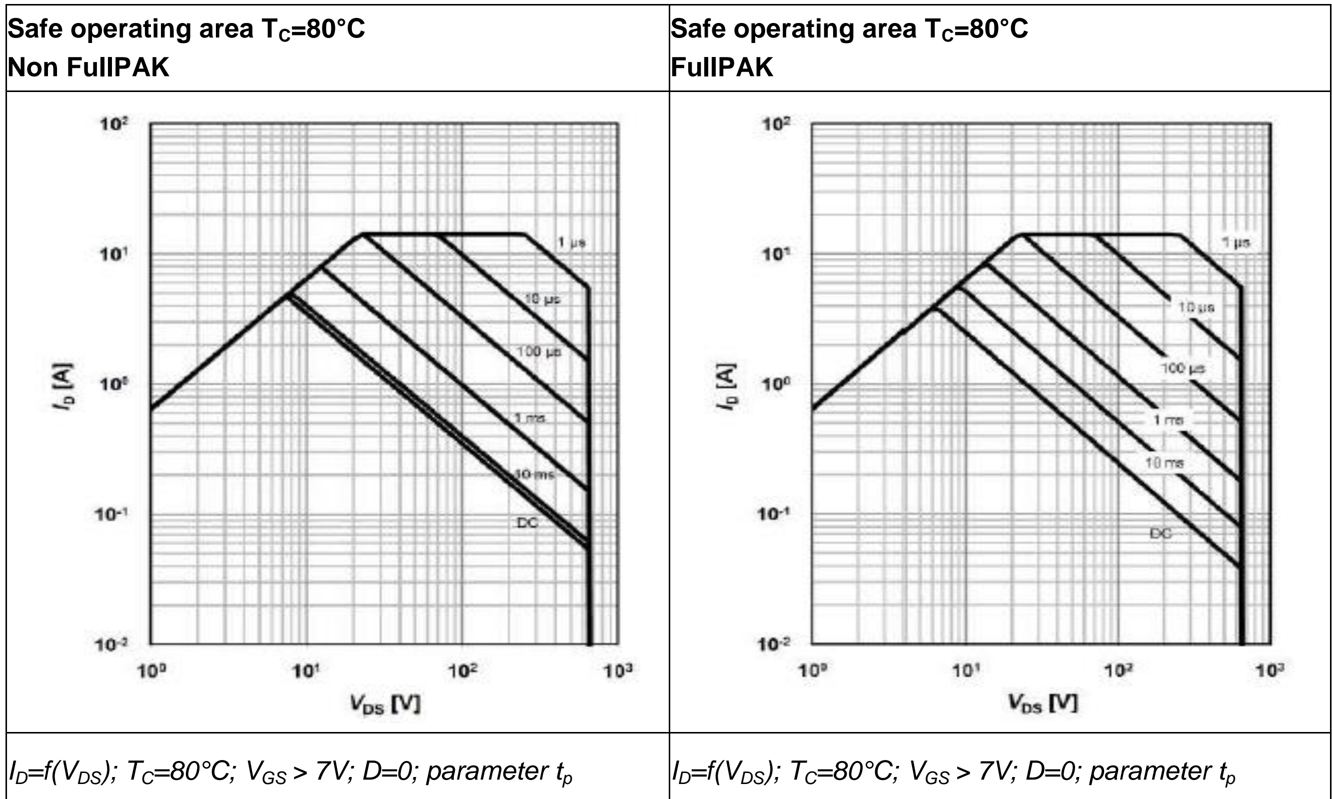
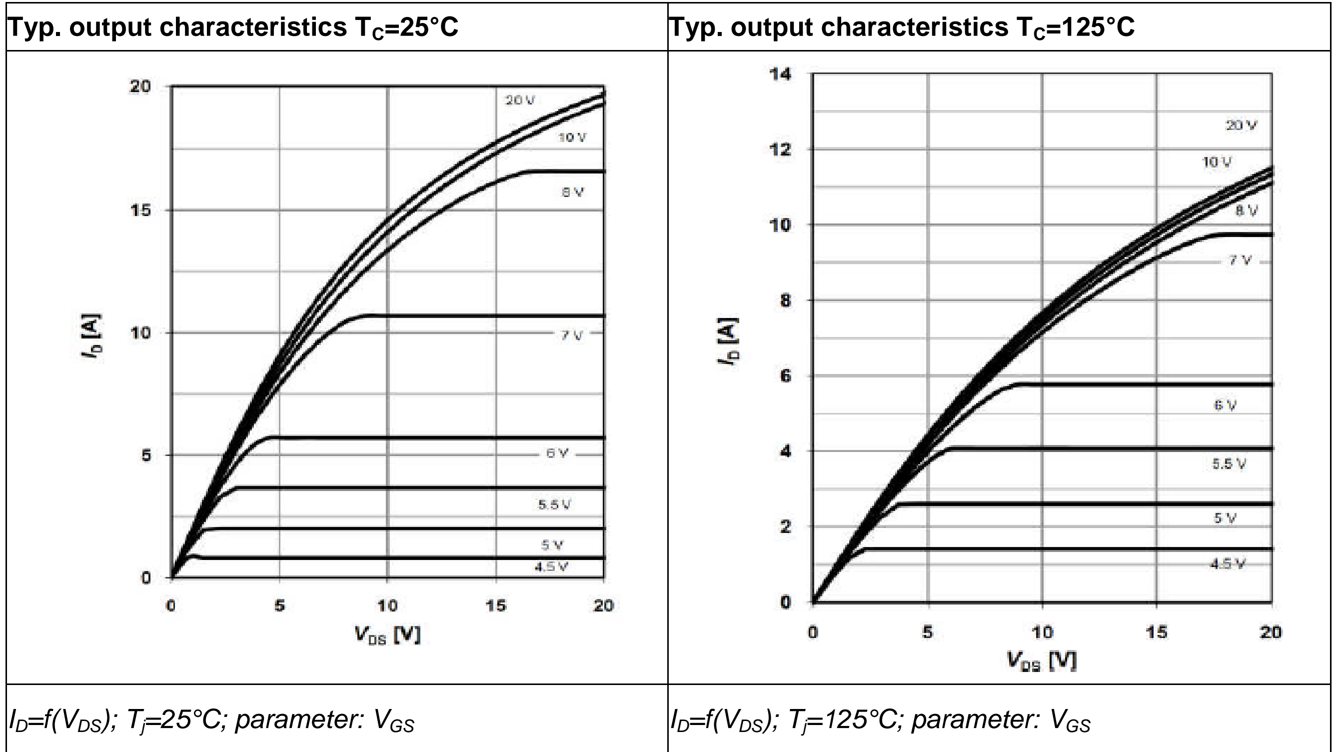
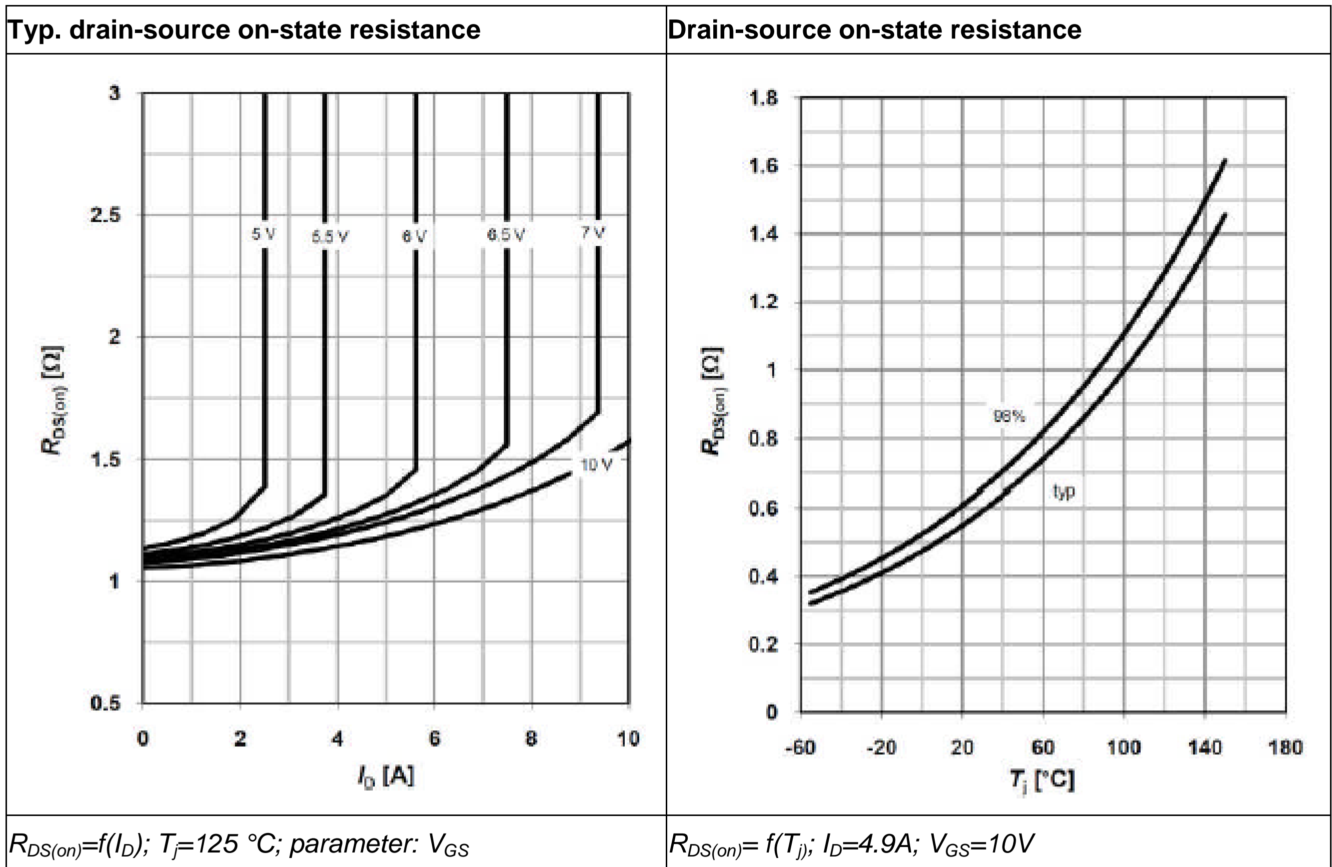
Safe operating area T_C=80°C Non FullPAK	Safe operating area T_C=80°C FullPAK
	
$I_D=f(V_{DS})$; T_C=80°C; V_{GS} > 7V; D=0; parameter t_p	$I_D=f(V_{DS})$; T_C=80°C; V_{GS} > 7V; D=0; parameter t_p

Table 14



Typ. output characteristics T_C=25°C	Typ. output characteristics T_C=125°C
I_D=f(V_{DS}); T_j=25°C; parameter: V_{GS}	I_D=f(V_{DS}); T_j=125°C; parameter: V_{GS}

Table 15



Typ. drain-source on-state resistance	Drain-source on-state resistance
$R_{DS(on)}$=f(I_D); T_j=125 °C; parameter: V_{GS}	$R_{DS(on)}$= f(T_j); I_D=4.9A; V_{GS}=10V

Table 16

Typ. transfer characteristics	**Typ. gate charge**
I_D=f(V_{GS}); V_{DS}=20V	V_{GS}=f(Q_{gate}), I_D=4.9 A pulsed

Table 17

Avalanche energy	**Drain-source breakdown voltage**
E_{AS}=f(T_j); I_D=1.8 A; V_{DD}=50 V	$V_{BR(DSS)}$=f(T_j); I_D=1.0 mA

Table 18

Typ. capacitances	Typ. C_{OSS} stored energy
$C=f(V_{DS})$; V_{GS}= 0 V; f=1 MHz	*$E_{OSS}=f(V_{DS})$*

Table 19

Forward characteristics of reverse diode
$I_F= f(V_{SD})$; parameter: T_j

6 Test circuits

Table 20 Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load	Switching time waveform

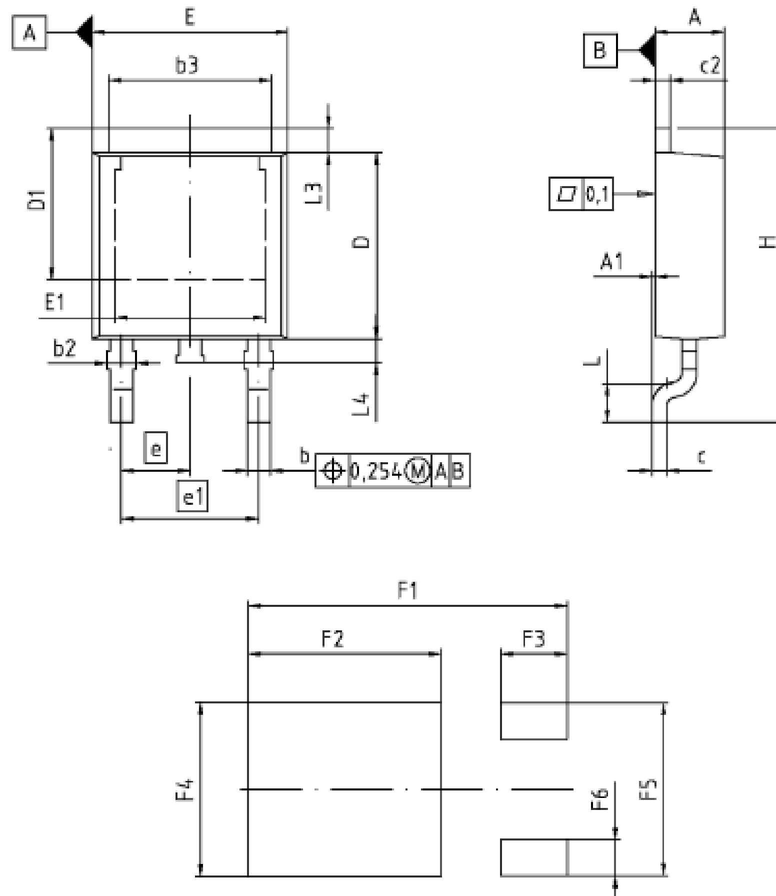
Table 11

Unclamped inductive load test circuit	Unclamped inductive waveform

Table 22

Test circuit for diode characteristics	Diode recovery waveform

7 Package outlines



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.16	2.41	0.085	0.095
A1	0.00	0.15	0.000	0.006
b	0.64	0.89	0.025	0.035
b2	0.65	1.15	0.026	0.045
b3	5.00	5.50	0.197	0.217
c	0.46	0.60	0.018	0.024
c2	0.46	0.98	0.018	0.039
D	5.97	6.22	0.235	0.245
D1	5.02	5.84	0.198	0.230
E	6.40	6.73	0.252	0.265
E1	4.70	5.21	0.185	0.205
e	2.29		0.090	
e1	4.57		0.180	
N	3		3	
H	9.40	10.48	0.370	0.413
L	1.18	1.70	0.046	0.067
L3	0.90	1.25	0.035	0.049
L4	0.51	1.00	0.020	0.039
F1	10.50	10.70	0.413	0.421
F2	6.30	6.50	0.248	0.256
F3	2.10	2.30	0.083	0.091
F4	5.70	5.90	0.224	0.232
F5	5.66	5.86	0.223	0.231
F6	1.10	1.30	0.043	0.051

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SCALE 0 2.0 0 2.0 4mm

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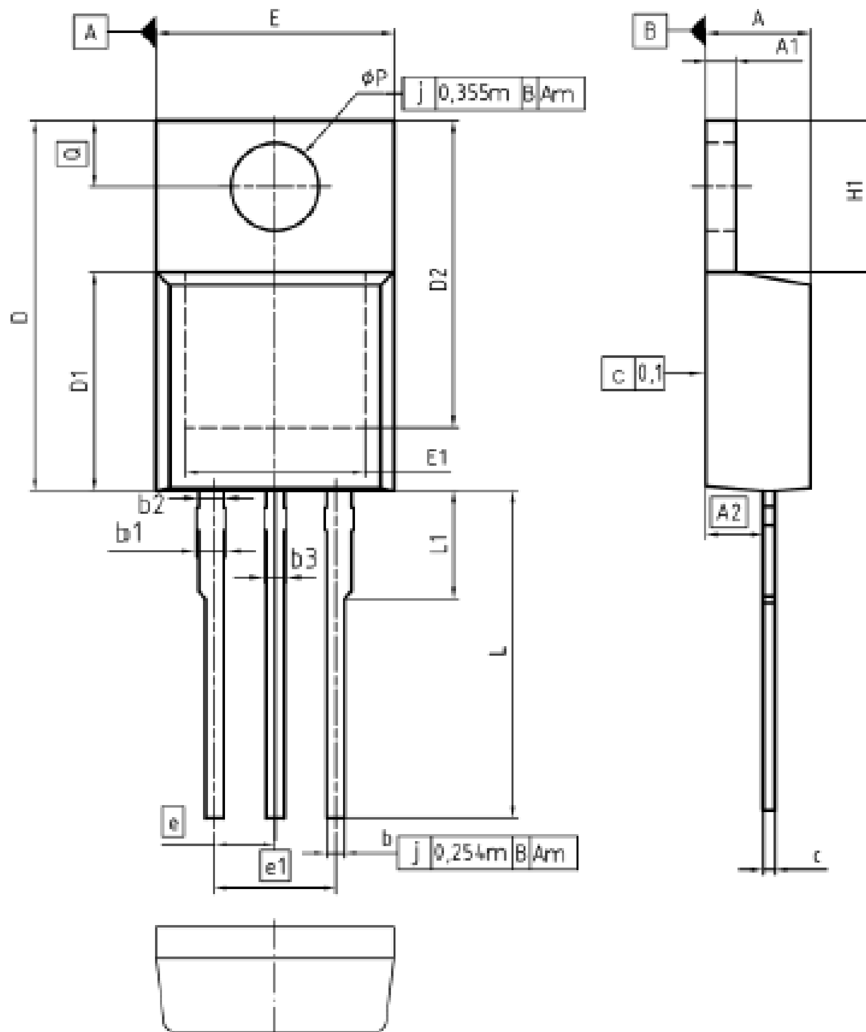
03

Figure 1 Outlines TO-252,, dimensions in mm/inches



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.30	4.57	0.169	0.180
A1	1.17	1.40	0.046	0.055
A2	2.15	2.72	0.085	0.107
b	0.65	0.86	0.026	0.034
b1	0.95	1.40	0.037	0.055
b2	0.95	1.15	0.037	0.045
b3	0.65	1.15	0.026	0.045
c	0.33	0.60	0.013	0.024
D	14.81	15.95	0.583	0.628
D1	8.51	9.45	0.335	0.372
D2	12.19	13.10	0.480	0.516
E	9.70	10.36	0.382	0.408
E1	6.50	8.60	0.256	0.339
e	2.54		0.100	
e1	5.08		0.200	
N	3		3	
H1	5.90	6.90	0.232	0.272
L	13.00	14.00	0.512	0.551
L1	-	4.80	-	0.189
øP	3.60	3.89	0.142	0.153
Q	2.60	3.00	0.102	0.118

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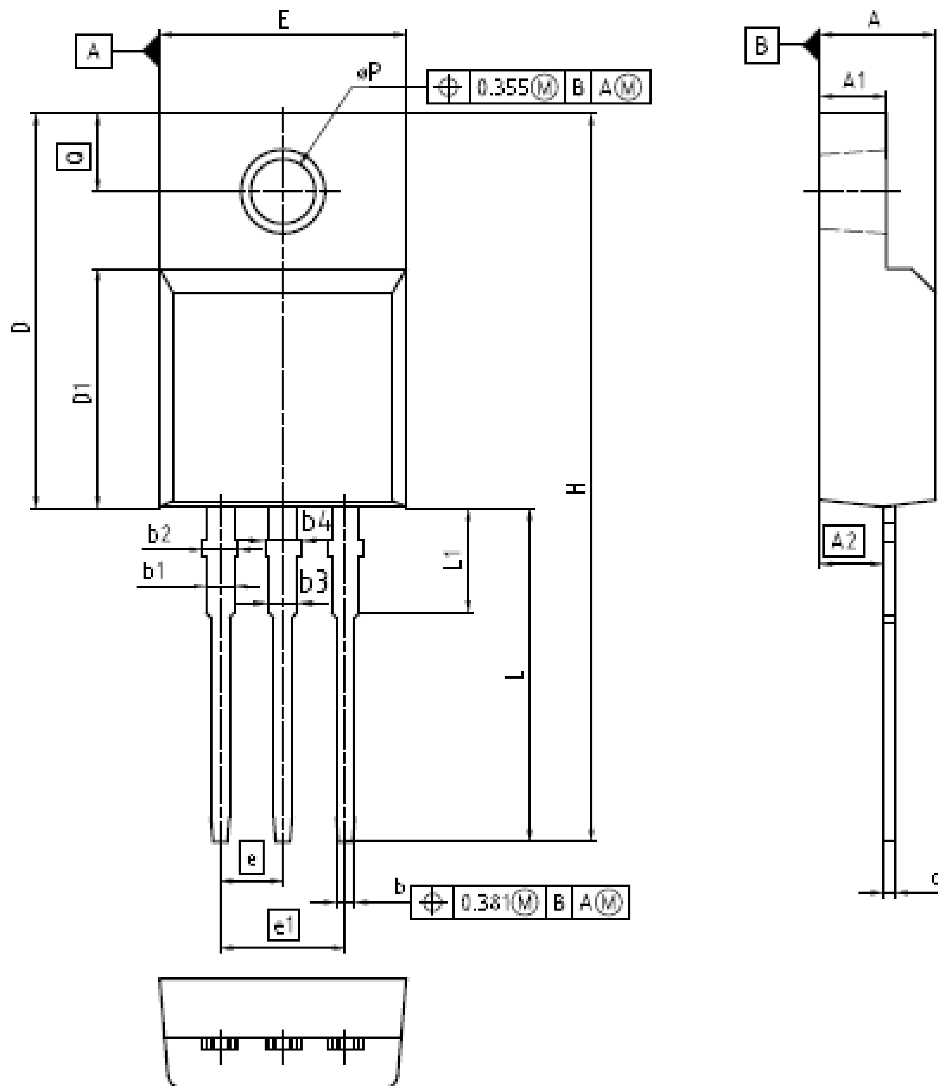
Figure 2 Outlines TO220, dimensions in mm/inches



DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.50	4.90	0.177	0.193
A1	2.34	2.85	0.092	0.112
A2	2.42	2.86	0.095	0.113
b	0.65	0.90	0.026	0.035
b1	0.95	1.38	0.037	0.054
b2	0.95	1.51	0.037	0.059
b3	0.65	1.38	0.026	0.054
b4	0.65	1.51	0.026	0.059
c	0.40	0.63	0.016	0.025
D	15.67	16.15	0.617	0.636
D1	8.97	9.83	0.353	0.387
E	10.00	10.65	0.394	0.419
e	2.54 (BSC)		0.100 (BSC)	
e1	5.08		0.200	
N	3		3	
H	28.70	29.75	1.130	1.171
L	12.78	13.75	0.503	0.541
L1	2.83	3.45	0.111	0.136
øP	2.95	3.38	0.116	0.133
Q	3.15	3.50	0.124	0.138

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Figure 3 Outlines TO220 FullPAK, dimensions in mm/inches

8 Revision History

Revision History: 2016-08-04, Rev. 2.2	
Previous Revision:	
Revision	**Subjects (major changes since last version)**
2.0	Release of final data sheet
2.1	Update halogen free mold compound status of PG-TO252 package
2.2	Update PG-TO220 FullPAK drawing on page 16

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